Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/609,633	WISNIEWSKI ET AL.	
Examiner	Art Unit	
Khai M. Nguyen	2617	

SEARCHED				
Class	Subclass	Date	Examiner	
see	previous		KN	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
see previous		KN	
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